

16-CH PROGRAMMABLE CAPACITIVE TOUCH SENSOR

GENERAL DESCRIPTION

IS31SE5117A is an ultra-low-power, 16-channel capacitive touch controller. The controller allows sleep mode (under 10uA) and uses auto-detection for wakeup. It also provides a shield output to increase moisture immunity. The built-in hardware monitor and calibration for the environment is to prevent false triggers.

A host MCU is required to communicate with IS31SE5117A. An on-chip I²C slave controller with 400kHz capability serves as the communication port for the host MCU. An interrupt, INT, can be configured and it is generated when a touch trigger event occurs. Trigger conditions can be configured by setting the interrupt register. IS31SE5117A can support proximity sensing.

IS31SE5117A is available in the QFN-24 package. It operates from 2.7V to 5.5V over the temperature range from -40°C to +105°C.

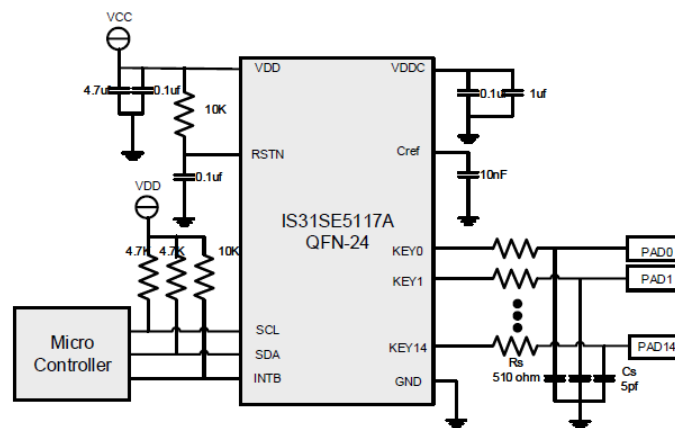
APPLICATIONS

- Touch keys for home appliances
- Touch keys for industrial control

FEATURES

- 16-channel capacitive touch controller with readable key value
- Touch threshold setting for individual key
- Optional multiple-key function
- GPIO toggle/invert function
- Automatic calibration
- Individual key calibration
- Interrupt output with auto-clear and repeating
- Auto sleep mode for extremely low power
- Keys wake up from sleep mode
- Shield output shared with touch key channels
- Buzzer/Melody Generator shared with touch key channels
- 400kHz fast-mode I²C interface
- Operating temperature between -40°C ~ +105°C
- QFN-24
- ROHS & Halogen-Free compliant package
- TSCA compliance

TYPICAL APPLICATION CIRCUIT (QFN-24)



Note 1: The IC should be placed far away from the noise source to prevent EMS.

Note 2: The R_s and C_s should be placed as close to the IC as possible to reduce EMI.

Note 3: The AD pin can be configured as KEY15.

Note 4: The capacitors connected to VDD and VDDC should be as close to the IC as possible to reduce EMI.

Note 5: The capacitor 1uF connected to VDDC might need to be removed for quick VDD rising time application.

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PINOUT

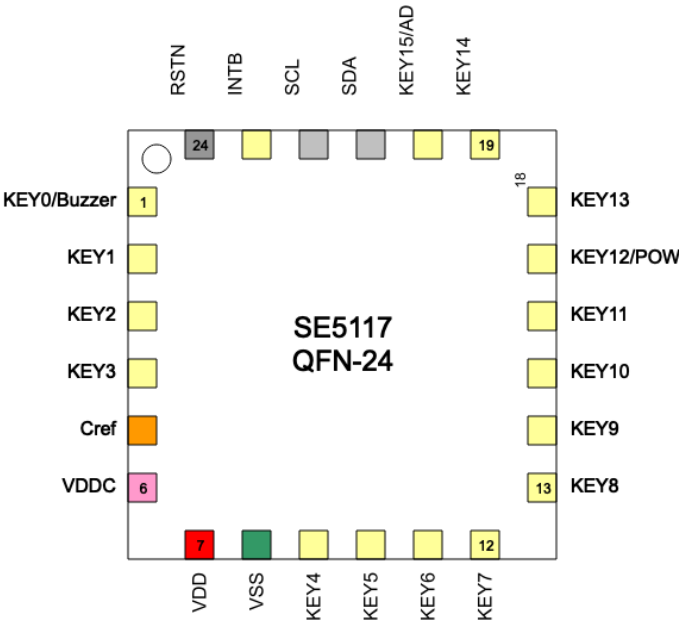


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1. PIN DESCRIPTION

No.	Pin	Description
1	KEY0/Buzzer	Multiple function key. Can be configured to input sense channel 0, or Buzzer output.
2 - 4	KEY1 – KEY3	Input sense channel 1 – 3
5	Cref	External reference Capacitor for touch sense
6	VDDC	Internal 1.5V power supply. Typical decoupling capacitors of 0.1μF and 1μF should be connected. between VDDC and GND.
7	VDD	Power supply
8	VSS	Ground
9 – 16	KEY4 – KEY11	Input sense channel 4 - 11
17	KEY12/POW	Multiple function key. Can be configured to input sense channel 12, or Melody power control.
18 – 19	KEY13 – KEY14	Input sense channel 13 - 14
20	AD/KEY15	Multiple function key. Can be configured to I2C address or input sense channel 15.
21	SDA	I2C serial data
22	SCL	I2C serial clock
23	INTB	Interrupt output (active low)
24	RSTN	Reset Low Active

Table 1-1 PIN Description

IS31SE5117A

2. ORDERING INFORMATION

Industrial Range: -40°C to +105°C

Order Part No.	Package	QTY
IS31SE5117A-QFLS3-TR	QFN-24, Lead-free	2500/Reel

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- a.) the risk of injury or damage has been minimized;
- b.) the user assumes all such risks; and
- c.) potential liability of Lumissil Microsystems is adequately protected under the circumstances.

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3. ABSOLUTE MAXIMUM RATINGS

Supply voltage, VDD	-0.3V ~ +6.0V
Voltage at any input pin	-0.3V ~ VDD+0.3V
Maximum junction temperature, TJMAX	+150°C
Storage temperature range, TSTG	-65°C ~ +150°C
Operating temperature range TA	-40°C ~ +105°C
Junction Package thermal resistance, junction to ambient (4 layer standard test PCB based on JESD 51-2A), $\theta_{JA}(QFN-24)$	29°C/W
ESD (HBM)	±2kV
ESD (CDM)	±750V

Table 3-1 Absolute maximum ratings

Note 6: Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

3.1 ELECTRICAL CHARACTERISTICS

TA = 25°C, VDD = 2.7V ~ 5.5V, unless otherwise noted. Typical values are TA = 25°C, VDD = 3.6V.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
VDD	Supply voltage		2.7		5.5	V
IDD	IDD core current per frequency	VDD = 5.5V		150		μA/Mhz
IDD sleep	IDD, sleep mode, 25°C	VDD = 5.5V		4		μA
ΔCS	Minimum detectable capacitance	CS = 5pF (Note 7)		0.2		pF
Logic Electrical Characteristics						
VIL	Logic “0” input voltage	VDD = 2.7V			0.4	V
VIH	Logic “1” input voltage	VDD = 5.5V	1.4			V
IIL	Logic “0” input current	VINPUT = 0V (Note 7)		5		nA
IIH	Logic “1” input current	VINPUT = VDD (Note 7)		5		nA

3.2 DIGITAL INPUT SWITCHING CHARACTERISTICS (Note 7)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
fSCL	Serial-Clock frequency				400	kHz
tBUF	Bus free time between a STOP and a START condition		1.3			μs
tHD, STA	Hold time (repeated) START condition		0.6			μs
tSU, STA	Repeated START condition setup time		0.6			μs
tSU, STO	STOP condition setup time		0.6			μs
tHD, DAT	Data hold time				0.9	μs
tSU, DAT	Data setup time		100			ns
tLOW	SCL clock low period		1.3			μs
tHIGH	SCL clock high period		0.7			μs
tR	Rise time of both SDA and SCL signals.	(Note 8)		20+0.1Cb	300	ns
tF	Fall time of both SDA and SCL signals.	(Note 8)		20+0.1Cb	300	ns

Note 7: Guaranteed by design.

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Note 8: C_b = total capacitance of one bus line in pF. $I_{SINK} \leq 6\text{mA}$. t_R and t_F measured between $0.3 \times V_{DD}$ and $0.7 \times V_{DD}$.

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4. FUNCTION BLOCK DIAGRAM

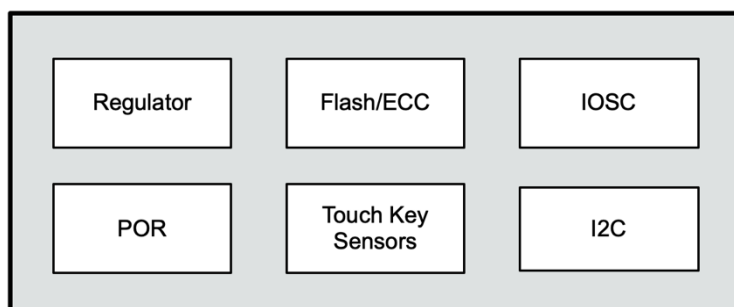


Figure 4-1 Function Block Diagram

4.1 Basic introduction for touch sense data process flow

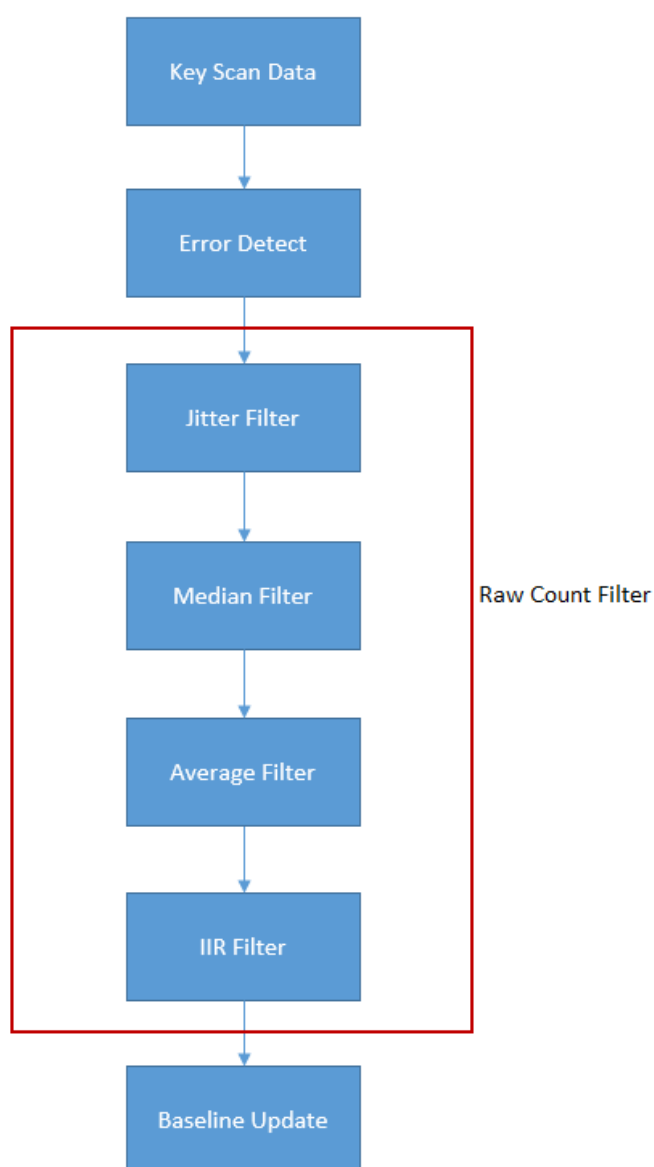


Figure 4-2 Touch Sense Data Process Flow

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4.2 Baseline process based on difference of baseline and raw count

Baseline will be updated to the current raw count based on the below factors. For detailed information about baseline, please refer to Section 4.4.2 Key parameter in “IS31SE5117A Eval Board User’s Manual with Safety Self-Test” application note.

4.2.1 Positive noise threshold

Baseline is updated if the difference count of baseline count and raw count is below the positive noise threshold.

4.2.2 Negative noise threshold

It is used with the low baseline reset count to reset baseline count to the current raw count. Please refer to the description of Low baseline reset.

4.2.3 Low baseline reset

Low baseline reset count of each key. A reset count increases one if the absolute $|raw\ count - baseline| > negative\ noise\ threshold$. Once the reset count exceeds the low baseline reset register value, the baseline is reset to the current raw count. The reset count will be reset to 0 if the absolute $|raw\ count - baseline| \leq negative\ noise\ threshold$.

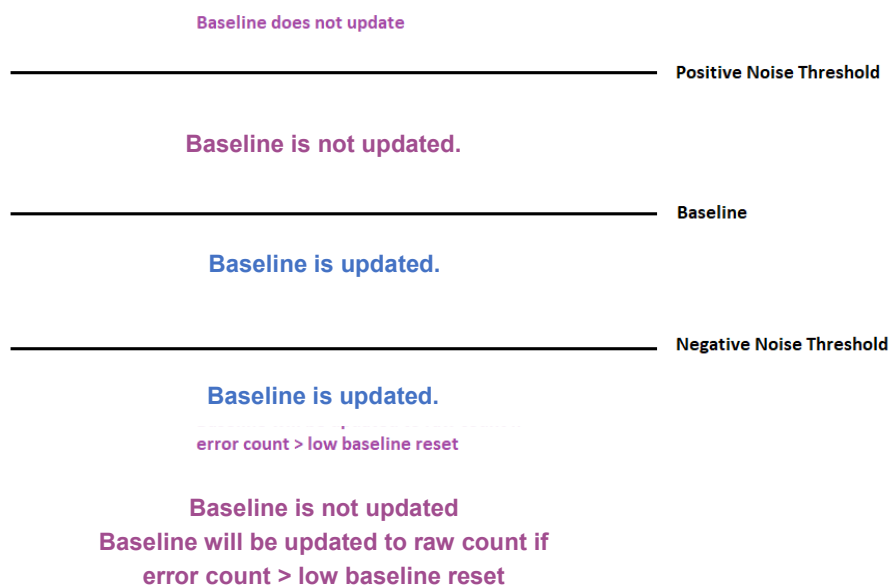


Figure 4-3 Baseline Process based on difference of baseline and raw count

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4.2.4 Touch sense data identification

Ignore touch key scan if the signal exceeds the lock threshold.

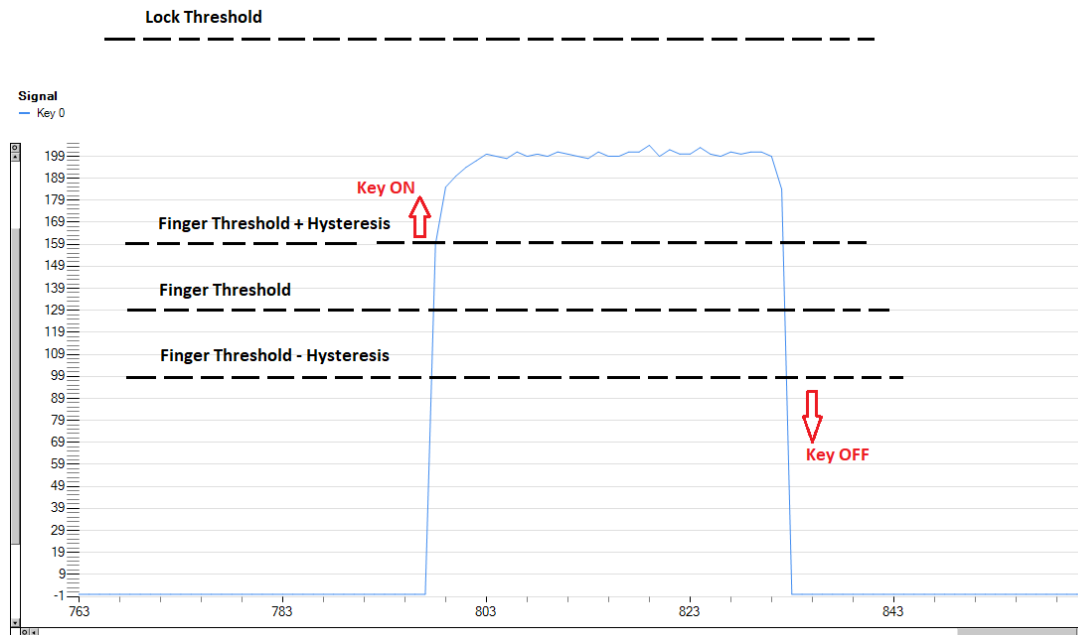


Figure 4-4 Touch Sense Data Identification

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5. DETAILED DESCRIPTION

5.1 I2C INTERFACE

The IS31SE5117A uses a serial bus, which conforms to the I2C protocol, to control the chip's functions with two wires: SCL and SDA. IS31SE5117A has a 7-bit slave address (A7:A1), followed by the R/W bit, A0. Set A0 "0" for a write command and set A0 "1" for a read command. The value of bits A1 and A2 are determined by the connection of the AD pin, to GND, VDD, or Floating.

The complete slave address is:

Bit	A7:A3	A2:A1	A0
Value	01111	AD	1/0

AD floating, AD = 00;

AD connected to GND, AD = 01;

AD connected to VDD, AD = 10;

AD pin can also be configured as a Touch Key channel. When AD pin is used for a Touch Key channel, A2: A1 = 00.

The SCL line is uni-directional. The SDA line is bi-directional (open collector) with a pull-up resistor (typically 4.7kΩ). The maximum clock frequency specified by the I2C standard is 400kHz. During communication, the microcontroller is the master and IS31SE5117A is the slave.

The timing diagram for the I2C is shown in Figure 5-1. The SDA is latched on to the stable high level of the SCL. When there is no bus activity, the SDA line should be held high.

The "START" signal is generated by lowering the SDA signal while the SCL signal is high. The start signal will alert all devices attached to the I2C bus to check the incoming address against their own chip address.

The 8-bit chip address is sent next, and the most significant bit first. Each address bit must be stable while the SCL level is high.

After the last bit of the chip address is sent, the master checks for IS31SE5117A acknowledgement. The master releases the SDA line high (through a pull-up resistor). Then the master sends an SCL pulse. If IS31SE5117A has received the address correctly, then it holds the SDA line low during the SCL pulse. If the SDA line is not low, then the master should send a "STOP" signal (discussed later) and abort the transfer.

Following acknowledge of IS31SE5117A, the register address byte is sent, and the most significant bit first. IS31SE5117A must generate another acknowledgment indicating that the register address has been received.

Then 8-bit of data bytes are sent next, the most significant bit first. Each data bit should be valid while the SCL level is stable high. After the data byte is sent, IS31SE5117A must generate another acknowledgment to indicate that the data was received.

The "STOP" signal ends the transfer. To signal "STOP", the SDA signal goes high while the SCL signal is high.

5.2 READING PORT REGISTERS

To read the device data, the bus master must first send the address of IS31SE5117A with the R/W bit set to "0", followed by the command byte, which determines which register is accessed. After a restart, the bus master must send IS31SE5117A address with the R/W bit set to "1". Data from the register defined by the command byte is sent from IS31SE5117A to the master (Figure 5-4).

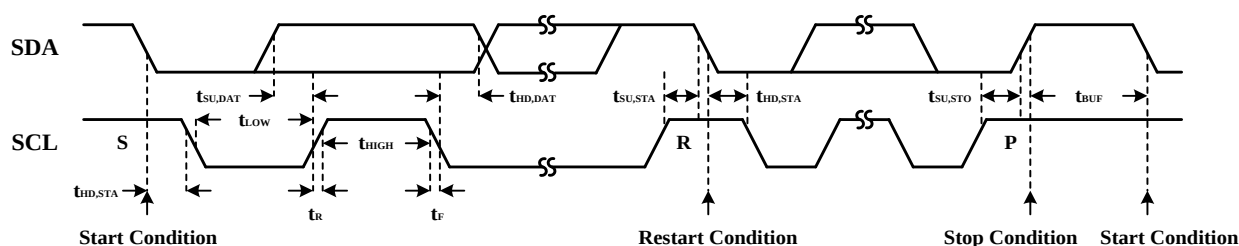


Figure 5-1 Interface Timing

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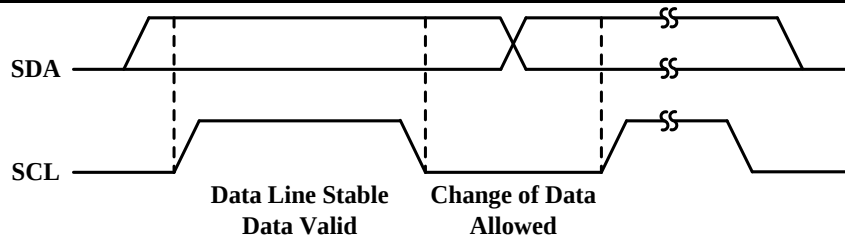


Figure 5-2 Bit Transfer

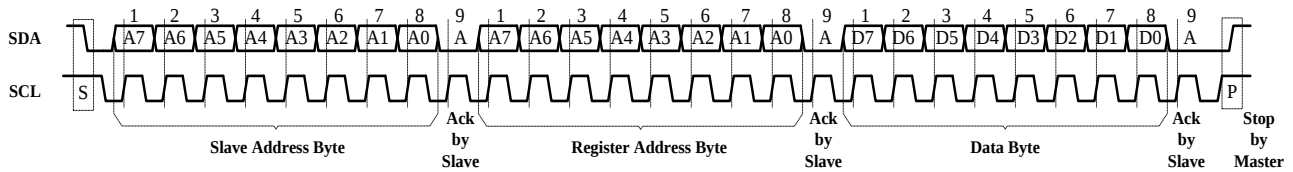


Figure 5-3 Writing to IS31SE5117A

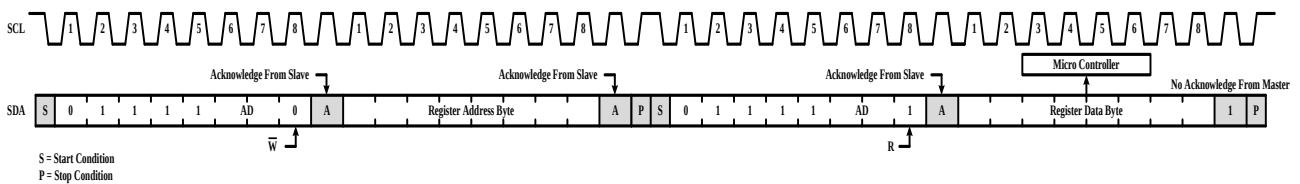


Figure 5-4 Reading from IS31SE5117A

Note: Successive read or write protocol is supported.

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6. REGISTER DEFINITION

6.1 Page 0 Register list

Address	Name	Definition	R/W	Default
00h	Chip Part Number	Chip's part number	R	17h
01h-02h	Chip Version	Chip's version	R	-
03h	Firmware Version	Firmware version	R	60h
04h	Run Version	Run version	R/W	60h
05h	Main Control	System reset, power saving, and parameters management	W	00h
06h	Switch Page	Switch for Page 0 and Page 1	R/W	00h
07h-08h	Key Status	Key 0-Key 15 status bits	R	00h
09h	BM	Buzzer data or stop command	W	-
09h	BM	Available buzzer buffer size	R	0Ah
0Ah-19h	Key Signal	Key 0-Key 15 signal value	R	00h
1Ah-39h	Key Raw Count	Key 0-Key 15 raw count value	R	00h
3Ah-59h	Key Baseline	Key 0-Key 15 baseline value	R	00h
5Ah	Raw Count Filter	Raw count filter setting	R/W	00h
5Bh	Baseline IIR Ratio	Baseline IIR ratio setting	R/W	01h
5Ch-5Dh	Lock Threshold	Lock threshold setting	R/W	03E8h
5Eh	Lock Scan Cycle	Lock scan cycle setting	R/W	08h
5Fh	Raw Count Difference Limit	Raw count difference limit setting	R/W	64h
60h	Multi Touch Key Configure	Multiple touch key function setting	R/W	03h
61h	Max Duration Time	Maximum duration time setting	R/W	1Ah
62h	Interrupt Configuration	Interrupt configuration	R/W	0Ah
63h	Interrupt Repeat Time	Repeat cycle for pressing key interrupt setting	R/W	00h
64h	Key Pin Select	Select pins as Key0-Key7	R/W	00h
65h	Key Pin Select	Select pins as Key8-Key15	R/W	00h
66h-67h	Shield Pin Select	Select pin as shield	R/W	0040h
68h-69h	INT Pin Select	Select pin as INT	R/W	0000h
6Ah-6Bh	Buzzer Pin Select	Select pin as buzzer	R/W	0100h
6Ch-6Dh	POW Pin Select	Select pin as buzzer power	R/W	0000h
6Eh	GPIO Pin Select	Select pin as GPIO0-GPIO7	R/W	0Eh
6Fh	GPIO Pin Select	Select pin as GPIO8-GPIO15	R/W	00h
70h-71h	Slider 1 Key Select	Select Key as slider 1, max 8 keys	R/W	003Fh
72h-73h	Slider 2 Key Select	Select Key as slider 2, max 8 keys	R/W	0000h
74h	TKIII Control register 1	Repeat sequence, initial setting delay, auto mode start delay, and low-frequency noise filter	R/W	13h
75h	TKIII Control register 2	Pseudo random sequence setting	R/W	20h
76h	TKIII Control register 3	Multi frequency scan/cycle count setting	R/W	03h
77h	TKIII CCHG	Internal charge capacitance setting	R/W	60h
78h	TKIII PUD	Pull-up current/ pull-up resistors setting	R/W	00h

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Address	Name	Definition	R/W	Default
79h	System Clock Select	System clock setting	R/W	01h
7Ah	Spread Spectrum	Spread spectrum setting	R/W	0Ch
7Bh	Auto Sleep Mode	Auto-enter sleep mode time setting	R/W	0Fh
7Ch	Sleep Mode Control	Sleep mode control setting	R/W	00h
7Dh-7Eh	Wake Up Key Select	Select Key0~Key15 to exit sleep mode	R/W	0000h
7Fh	Wake Up Threshold	Wake up threshold setting	R/W	08h
80h	TKIII Sleep Mode CCHG	Sleep mode internal charge capacitance setting	R/W	60h
81h	TKIII Sleep Mode PUD	Sleep mode pull-up current/ pull-up resistors setting	R/W	00h
82h-83h	SLP_RAW	Sleep mode raw count value	R	0000h
84h-85h	SLP_Baseline	Sleep mode baseline value	R	0000h
86h-8Bh	Slider 1-2 status	3 slider status registers for each slider	R/W	Addr. 88h Value 80h, others Value 00h
8Ch	Slider 1 Mapping	Slider 1 Key 1 position	R/W	08h
8Dh	Slider 1 Mapping	Slider 1 Key 2 position	R/W	09h
8Eh	Slider 1 Mapping	Slider 1 Key 3 position	R/W	0Ah
8Fh	Slider 1 Mapping	Slider 1 Key 4 position	R/W	0Bh
90h	Slider 1 Mapping	Slider 1 Key 5 position	R/W	0Ch
91h	Slider 1 Mapping	Slider 1 Key 6 position	R/W	0Dh
92h	Slider 1 Mapping	Slider 1 Key 7 position	R/W	00h
93h	Slider 1 Mapping	Slider 1 Key 8 position	R/W	00h
94h-9Bh	Slider 2 Mapping	Slider 2 Key 1 – 8 positions	R/W	00h
9Ch	Self-Test Item	Safety function self-test item	R/W	00h
9Dh-9Eh	Self-Test Ram Start Addr	Safety function self-test ram start address	R/W	00h
9Fh-A0h	Self-Test Ram Size	Safety function ram size	R/W	00h
A1h	Self-Test Result	Safety function self-test test result	R	00h
A2h-FFh	Reserved	Reserved	-	-

Table 6-1 Page 0 Register list

6.2 Page 1 Register list (extension memory)

Address	Name	Definition	R/W	Default
0100h	Chip Part Number	Chip's part number	R	17h
0101h-0102h	Chip Version	Chip's version	R	-
0103h	Firmware Version	Firmware version	R	60h
0104h	Run Version	Run version	R/W	60h
0105h	Main Control	System reset, power saving, and parameters management	W	00h
0106h	Switch Page	Switch for Page 0 and Page 1	R/W	00h
0107h-0108h	Key Status	Key 0-Key 15 status bits	R	00h

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Address	Name	Definition	R/W	Default
0109h	BM	Buzzer data or stop command	W	-
0109h	BM	Available buzzer buffer size	R	0Ah
010Ah-0119h	Key Finger Threshold	Key 0-Key 15 finger threshold setting	R/W	50h or 28h
011Ah-0129h	Key Noise Threshold	Key 0-Key 15 noise threshold setting	R/W	28h or 14h
012Ah-0139h	Key Negative Noise Threshold	Key 0-Key 15 negative noise threshold setting	R/W	28h or 14h
013Ah-0149h	Key Low Baseline Reset	Key 0-Key 15 low baseline reset setting	R/W	1Eh
014Ah-0159h	Key Hysteresis	Key 0-Key 15 hysteresis setting	R/W	08h or 04h
015Ah-0169h	Key ON Debounce	Key 0-Key 15 debounce setting	R/W	03h
016Ah-016Bh	Key Interrupt Enable	Key 0-Key 15 enables Interrupts associated with capacitive touch sensor inputs	R/W	00h
016Ch	GPIO Value 1	Default GPIO values for GPIO0 – GPIO7	R/W	0Eh
016Dh	GPIO Value 2	Default GPIO values for GPIO8 – GPIO15	R/W	00h
016Eh	GPIO Enable 1	Enable KEY0- KEY7 to do GPIO mapping	R/W	70h
016Fh	GPIO Enable 2	Enable KEY8- KEY15 to do GPIO mapping	R/W	00h
0170h	GPIO Mapping 1	Key to GPIO mapping	R/W	00h
0171h	GPIO Mapping 2	Key to GPIO mapping	R/W	00h
0172h	GPIO Mapping 3	Key to GPIO mapping	R/W	12h
0173h	GPIO Mapping 4	Key to GPIO mapping	R/W	03h
0174h-0177h	GPIO Mapping 5-8	Key to GPIO mapping	R/W	00h
0178h	GPIO Toggle EN 1	Enable GPIO Toggle mode for KEY0 – KEY7	R/W	10h
0179h	GPIO Toggle EN 2	Enable GPIO Toggle mode for KEY8 – KEY15	R/W	00h
017Ah	Key Scan Once	I2C control key scan	R/W	00h
017Bh	Table Ready Mark	Mark for flash data ready	R	00h

Table 6-2 Page 1 Register list (extension memory)

6.3 Page 0 Registers

00h Chip Part Number Register (RO)

Bit	D7:D0
Name	CPN[7:0]
Default	0001 0111

CPN

Chip Part Number

Chip's part number 17h

01h Chip Version Register 1 (RO)

Bit	D7:D0
Name	CV1[7:0]
Default	-

CV1

Chip Version information 1

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02h Chip Version Register 2 (RO)

Bit	D7:D0
Name	CV2[7:0]
Default	-

CV2

Chip Version information 2

CV1 & CV2 bytes contain chip revision. CV1 indicates mask set version. CV2 indicates minor version.

03h Firmware Version Register (RO)

Bit	D7:D0
Name	FV1[2:0] FV2[2:0] FV3[1:0]
Default	011 000 00

FV

Firmware Version

Default version is 3.0.0

FV1[2:0]

Major version

FV2[2:0]

Minor version

FV3[1:0]

Patch version

04h Run Version Register (RW)

Bit	D7:D0
Name	RV1[2:0] RV2[2:0] RV3[1:0]
Default	011 000 00

RV

Run Version

Set run firmware version and the default value equals to the default value of the firmware version register.

RV1[2:0]

Major version

RV2[2:0]

Minor version

RV3[1:0]

Patch version

05h Main Control Register (WO)

Bit	D7	D6	D5	D4	D3	D2	D1	D0
Name	SR	RD	-	SP	SS	DW	DS	-
Default	0	0	0	0	0	0	0	0

SR

System Reset

1 System reset

RD

Reset All Parameters to Manufacturer Default Setting.

1 Reset all user-defined parameters to manufacture default setting.

SP

Sleep Mode

1 Sleep mode

SS

Save User-Defined Parameters

1 Save current parameters into flash.

DW

Deep Sleep Wake Up Reset Baseline

1 Reset touch key baseline after waking up from deep sleep mode.

DS

Deep Sleep Mode

1 Keep sleep until waking up by I2C SDA falling edge.

06h Switch Page (RW)

Bit	D7	D6	D5	D4	D3	D2	D1	D0
Name	-	-	-	-	-	-	-	FLAG
Default	0	0	0	0	0	0	0	0

FLAG=0 Page 0 (Address: 0x00~0xFF)

FLAG=1 Page 1 (Address: 0x100~0x1FF)

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07h Key Status Register 1 (RO)

Bit	D7:D0
Name	KS[7:0]
Default	0000 0000

KSx

Key0~Key7 Status

If the key is detected as pressed, the corresponding bit (KSx) will be set to "1".

0 Not detected.

1 Key is detected.

08h Key Status Register 2 (RO)

Bit	D7:D0
Name	KS[15:8]
Default	0000 0000

KSx

Key8~Key15 Status

If the key is detected as pressed, the corresponding bit (KSx) will be set to "1".

0 Not detected.

1 Key is detected.

09h Buzzer Register (W)

Bit	D7:D0
Name	BM[7:0]
Default	-

BM

Buzzer Register Write

Buzzer data or stop command

09h Buzzer Register (R)

Bit	D7:D0
Name	BM[7:0]
Default	0000 1010

BM

Buzzer Register Read

It shows the available tone buffer size. IS31SE5117A has 10 built-in note buffers.

0Ah~19h KEY0~KEY15 Signal Register (RO)

Bit	D7:D0
Name	KEYx_SIGNAL[7:0]
Default	0000 0000

KEYx_SIGNAL

Key Signal Count

The difference between baseline and raw count.

The maximum value is 254. It will keep 254 if the value is over 254. Value 255 means noise existence.

1Ah, 1Ch..., 36h, 38h KEY0~KEY15 Raw Count High Byte Register (RO)

Bit	D7:D0
Name	KEYx_RAWCOUNT[15:8]
Default	0000 0000

1Bh, 1Dh..., 37h, 39h KEY0~KEY15 Raw Count Low Byte Register (RO)

Bit	D7:D0
Name	KEYx_RAWCOUNT[7:0]
Default	0000 0000

KEYx_RAWCOUNT

Raw count of each key provides an indication of the magnitude of the sensor's capacitance.

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3Ah, 3Ch ..., 56h, 58h KEY0~KEY15 Baseline High Byte Register (RO)

Bit	D7:D0
Name	KEYx_BASELINE[15:8]
Default	0000 0000

3Bh, 3Dh ..., 57h, 59h KEY0~KEY15 Baseline Low Byte Register (RO)

Bit	D7:D0
Name	KEYx_BASELINE[7:0]
Default	0000 0000

KEYx_Baseline Baseline of each key

5Ah Raw Count Filter Register (RW)

Bit	D7	D6	D5:D4	D3	D2:D1	D0
Name	MF	AF	IIR[1:0]	JF	JD[1:0]	-
Default	0	0	00	0	00	0

MF Median Filter
0 Disable
1 Enable

AF Average Filter
0 Disable
1 Enable

IIR IIR Filter
00 Disable
01 1/2
10 1/4
11 1/8

JF Jitter Filter
0 Disable
1 Enable

JD Jitter Delta
00 1
01 2
10 4
11 8

5Bh Baseline IIR Ratio Register (RW)

Bit	D7:D0
Name	RATIO[7:0]
Default	0000 0001

RATIO Range 1 ~ 255

5Ch Lock Threshold High Byte Register (RW)

Bit	D7:D0
Name	LT[15:8]
Default	0000 0011

5Dh Lock Threshold Low Byte Register (RW)

Bit	D7:D0
Name	LT[7:0]
Default	1110 1000

LT Lock Threshold

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5Eh Lock Scan Cycle Register (RW)

Bit	D7:D0
Name	LSC[7:0]
Default	0000 1000

LSC

Lock Scan Cycle

Ignore the key scan data for the setting Lock scan cycle if the |raw count – baseline| > Lock threshold.

5Fh Raw Count Difference Limit Register (RW)

Bit	D7:D0
Name	RCDL[7:0]
Default	0110 0100

RCDL

Raw Count Difference Limit

Ignore the key scan data if the difference between previous raw count and current raw count exceeds the limit.

60h Multiple Touch Key Configure Register (RW)

Bit	D7:D2	D1:D0
Name	-	MTK[1:0]
Default	000000	11

MTK

Multi Touch Key

- 00 Allow all keys to be triggered at one time.
- 01 Allow one key to be triggered at one time.
- 10 Allow two keys to be triggered at one time.
- 11 Allow three keys to be triggered at one time.

61h Max Duration Time Register (RW)

Bit	D7	D6	D5	D4	D3:D0
Name	-	-	-	MDEN	MDT[3:0]-
Default	0	0	0	1	1010

MDEN

Maximum Duration Time Enable

- 0 Disable
- 1 Enable

MDT

Maximum Duration Time

- 0000 0.5s
- 0001 1s
- 0010 2s
- 0011 3s
- 0100 4s
- 0101 5s
- 0110 6s
- 0111 7s
- 1000 8s
- 1001 9s
- 1010 10s
- 1011 11s
- 1100 12s
- 1101 13s
- 1110 14s
- 1111 15s

MDT bits set the pressed time. When key pressed duration exceeds the programmed time (MDT), device will be forced to calibrate the pressed key. Set MDEN to “1” will enable this function.

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62h Interrupt Configuration Register (RW)

Bit	D7	D6:D4	D3	D2:D0
Name	INE	-	ACEN	ACT[2:0]
Default	0	000	1	010

INE	Interrupt Function Enable
0	Disable
1	Enable
ACEN	Auto-Clear Interrupt Enable
0	Disable
1	Enable
ACT	Auto-Clear Interrupt Time
000	10ms
001	20ms
010	30ms
011	40ms
100	50ms
101	100ms
110	150ms
111	200ms

When ACEN=0, the INT will keep low until device 07h and 08h registers are read, or the key is released. When ACEN=1, the INT will be released after ACT setting time is expired even 07h and 08h registers are not read, or key is still pressed.

63h Interrupt Repeat Time Register (RW)

Bit	D7:D4	D3:D0
Name	-	INTRT[3:0]
Default	0000	0000

INTRT	Interrupt Repeat Time
0000	disable
0001	50ms
0010	100ms
0011	150ms
0100	200ms
0101	250ms
0110	300ms
0111	350ms
1000	400ms
1001	450ms
1010	500ms
1011	600ms
1100	700ms
1101	800ms
1110	900ms
1111	1s

After INTRT is set, a second interrupt will be generated after the interrupt repeat time is expired If there is a key keeping pressed.

64h~65h Key Pin Select Register (RW)

Bit	D7:D0
Name	KS[15:8] KS[7:0]
Default	0000 0000 0000 0000

KS	Key Pin Selection Setting
0	Disable
1	Enable

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66h~67h Shield Pin Select Register (RW)

Bit	D7:D0	
Name	SHDE[15:8]	SHDE[7:0]
Default	0100 0000	0000 0000

SHDE Shield Enable (default for SHDE[14])
 0 Disable shield driver
 1 Enable shield driver

68h~69h INT Pin Select Register (RW)

Bit	D7:D0	
Name	IPS1[15:8]	IPS1[7:0]
Default	0000 0000	0000 0000

IS31SE5117A interrupt Pin has been fixed at Pin 23 INTB and it doesn't work to set INT Pin Select Register C9h and CAh.

6Ah~6Bh Buzzer Pin Select Register 1 (RW)

Bit	D7:D0	
Name	BPS2[7:0]	BPS1[7:0]
Default	---- --	---- -- 1

BPS1/2 Buzzer output Select 1/2
 Enable BPS1[0] will set Pin1 as Buzzer output pin.
 BPS1[7:1] & BPS2[7:0] unused register bits.

6Ch Enable Buzzer Power Register 1 (RW)

Bit	D7:D0	
Name	EBP1 [7:0]	
Default	---- --	

6Dh Enable Buzzer Power Register 2 (RW)

Bit	D7:D0	
Name	EBP2 [0]	
Default	--- 0 ---	

EBP1/2 Buzzer Power Select 1/2
 EBP1[7:0] unused register bits.
 EBP2[4] maps to KEY12, write 1 will enable KEY12 as Buzzer Power. Setting other EBP2 bits doesn't work.

6Eh~6Fh GPIO Pin Select Register (RW)

Bit	D7:D0	
Name	GPIO[15:8]	GPIO[7:0]
Default	0000 0000	0000 1110

70h~71h Slider1 Key Select Register (RW)

Bit	D7:D0	
Name	GPIO[15:8]	GPIO[7:0]
Default	0011 1111	0000 0000

72h~73h Slider2 Key Select Register (RW)

Bit	D7:D0	
Name	GPIO[15:8]	GPIO[7:0]
Default	0000 0000	0000 0000

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74h TKIII Control Register 1 (RW)

Bit	D7:D6	D5:D4	D3:D2	D1:D0
Name	RPT	INI	ASTDLY	LFNF
Default	00	01	00	11

RPT	Repeat Sequence Count
00	No repeat
01	Repeat 4 times
10	Repeat 8 times
11	Repeat 16 times
INI	Initial Setting Delay
	INI[1-0] defines the number of TKCLK periods for the initial settling of pin Cref. The delay is (INI[1-0] + 1) * 4 * TKCLK.
ASTDLY	Auto Mode Start Delay
	ASTDLY[1-0] inserts an inter-sequence idle time of (ASTDLY[1-0] + 1) * 256 TKCLK at each sequence start. This delay allows the stabilization time from normal mode to sleep mode.
LFNF	Low-Frequency Noise Filter Setting
00	Disable LFNE
	If the scan count with noise injection detection is larger than (LFNF [1-0] * 8), the scan result is ignored.

75h TKIII Control Register 2 (RW)

Bit	D7	D6	D5	D4	D3	D2:D1	D0
Name	-	-	PRS	-	-	-	-
Default	0	0	1	0	0	00	0

PRS	Pseudo Random Sequence
0	Disable PRS
1	Enable PRS

76h TKIII Control Register 3 (RW)

Bit	D7:D4	D3	D2:D0
Name	-	MFEN	CCNT[2:0]
Default	0000	0	011

MFEN	Multi Frequency Scan
0	Disable MF
1	Enable MF
CCNT	Cycle Count of Each Conversion Sequence
000	1024
001	2048
010	4096
011	8192
100	12288
101	16384
110	32768
111	65536

77h TKIII CCHG Register (RW)

Bit	D7:D5	D4:D0
Name	CCHG[2:0]	-
Default	011	00000

CCHG	Internal Reference Capacitance Select
000	10pF
001	20pF
010	30pF

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011	40pF
100	50pF
101	60pF
110	70pF

78h TKIII PUD Register (RW)

Bit	D7	D6	D5:D4	D3:D0
Name	PUDIEN	PUDREN	-	PUD [3:0]
Default	0	00	00	0000

TK3PUD is to configure a constant DC pull-up/pull-down on pin Cref to allow high capacitance touch-key detection. A DC pull-up/pull-down can compensate for the equivalent resistance which is caused by a high capacitance key. Connecting a constant current source or resistor can thus maintain touch key detection sensitivity. In general, we will try to maintain the raw count around half of CCNT for the case without key touched.

For DC current, PUD [3:0] enables 8uA/4uA/2uA/1uA current source. For Resistor, PUD [3:0] enables 5K/10K/20K/40K resistor.

PUDIEN Pull-up/Pull-down DC Current Enable	
PUDREN Pull-up/Pull-down DC Resistor Enable	
PUD	Pull up DC Current
1000	Enable 8uA current source.
0100	Enable 4uA current source.
0010	Enable 2uA current source.
0001	Enable 1uA current source.
PUD	Pull up Resistor
1000	Enable 5K resistor source.
0100	Enable 10K resistor source.
0010	Enable 20K resistor source.
0001	Enable 40K resistor source.

79h System Clock Select Register (RW)

Bit	D7:D4	D3	D2:D0
Name	SCS[3:0]	CLKS	TKCS[2:0]
Default	0000	0	001

SCS		System Clock Select
0000	16MHz / 1	
0001	16MHz / 2	
0010	16MHz / 4	
0011	16MHz / 6	
0100	16MHz / 8	
0101	16MHz / 10	
0110	16MHz / 12	
0111	16MHz / 14	
1000	16MHz / 16	
1001	16MHz / 32	
1010	16MHz / 64	
1011	16MHz / 128	
1100	16MHz / 256	
1101	16MHz / 256	
1110	16MHz / 256	
1111	16MHz / 256	
CLKS		Clock Stretching (For I2C)
0	Disable stretching	
1	Enable stretching	
TKCS		Touch Key Clock Select
000	System Clock / 2	
001	System Clock / 4	

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010	System Clock / 6
011	System Clock / 8
100	System Clock / 10
101	System Clock / 16
110	System Clock / 32
111	64KHz

7Ah Spread Spectrum Register (RW)

Bit	D7:D2		
Name	SSR[3:0]	SSA[1:0]	-
Default	0000	11	-

SS	Spread Spectrum Setting With spread spectrum technique, electromagnetic energy produced over a particular bandwidth is spread in the frequency domain, and that can reduce EMI. Two parameters are listed as follows:
SSR [3:0]	Defines the spread spectrum sweep rate. If the SSR[3:0] =0, then spread spectrum is disabled.
SSA [1:0]	Defines how to adjust the spread spectrum frequency bandwidth. The frequency is adjusted by adding SSA [1:0] range to the actual internal OSC control register. SSA [1:0]=11 +/- 32 SSA [1:0]=10 +/- 16 SSA [1:0]=01 +/- 8 SSA [1:0]=00 +/- 4

7Bh Auto Sleep Mode Register (RW)

Bit	D7	D6	D5:D4	D3:D0
Name	ASEN	-	BLMA[1:0]	AST[3:0]
Default	0	0	00	1111

ASE	N Auto-SLEEP Enable 0 Disable 1 Enable
BLMA	Baseline moving average Hardware baseline can be generated by slow moving average setting. 00 32 average 01 64 average 10 128 average 11 256 average
AST	Auto Sleep Time 0000 0.5s 0001 1s 0010 1.5s 0011 2s 0100 2.5s 0101 3s 0110 3.5s 0111 4s 1000 4.5s 1001 5s 1010 6s 1011 7s 1100 8s 1101 9s 1110 10s 1111 11s

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7Ch Sleep Mode Control Register (RW)

Bit	D7	D6	D5	D4	D3:D2	D1:D0
Name	-	PW	-	SC	T2[1:0]	T1[1:0]
Default	0	0	0	0	00	00

PW	Proximity Wakeup
	Disable: wake up>>scan key once>>go to sleep again
	Enable: wake up>> generates INT signal (optional) >>go to sleep after Auto Sleep Time is expired if no key is detected.
	0 Disable
	1 Enable
SC	Sleep Calibration
	0 Disable
	1 Enable
T2	Wake Up Period with Key Disable
	Device will be woken up according to the T2 setting by polling the status of Key.
	00 50ms
	01 100ms
	10 200ms
	11 300ms
T1	Wake Up Period with Key Enable
	Device will be woken up according to the T1 setting to maintain the baseline to prevent the change of environment from stopping Key waking up device.
	00 2s
	01 4s
	10 8s
	11 16s

7Dh~7Eh Wake Up Key Select Register (RW)

Bit	D7:D0	
Name	WK[15:8]	WK[7:0]
Default	0000 0000	0000 0000

WK	Wakeup Key Select Setting
	0 Disable
	1 Enable

7Fh Wake Up Threshold Register (RW)

Bit	D7:D0	
Name	WTH[7:0]	
Default	0000 1000	

Wake up threshold range from 0 to 255

80h TKIII Sleep Mode CCHG Register (RW)

Bit	D7:D5	D4:D0
Name	CCHG[2:0]	-
Default	011	00000

CCHG	Internal Reference Capacitance Select
	000 10pF
	001 20pF
	010 30pF
	011 40pF
	100 50pF
	101 60pF
	110 70pF
	111 80pF

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81h TKIII Sleep Mode PUD Register (RW)

Bit	D7	D6	D5:D4	D3:D0
Name	PUDIEN	PUDREN	-	PUD[3:0]
Default	0	0	00	0000

TK3 PUD is to configure a constant DC pull-up/pull-down on pin Cref to allow high capacitance touch-key detection. A DC pull-up/pull-down can compensate for the equivalent resistance caused by a high capacitance key. Connecting a switching current source or resistor can thus maintain touch key detection sensitivity.

For DC current, PUD[3:0] can enable 8uA/4uA/2uA/1uA current source. For Resistor, PUD[3:0] can enable 5K/10K/20K/40K resistor

PUDIEN Pull-up/Pull-down DC Current Enable

PUDREN Pull-up/Pull-down DC Resistor Enable

PUD	Pull up DC Current
1000	Enable 8uA current source.
0100	Enable 4uA current source.
0010	Enable 2uA current source.
0001	Enable 1uA current source.
PUD	Pull up Resistor
1000	Enable 5K resistor source.
0100	Enable 10K resistor source.
0010	Enable 20K resistor source.
0001	Enable 40K resistor source.

82h Sleep Mode Raw Count Register 1 (RO)

Bit	D7:D0
Name	SLRC[15:8]
Default	0000 0000

83h Sleep Mode Raw Count Register 2 (RO)

Bit	D7:D0
Name	SLRC[7:0]
Default	0000 0000

SLRC Sleep Mode Raw Count
Read only. Value for reference

84h Sleep Mode Baseline Register 1 (RO)

Bit	D7:D0
Name	SLB[15:8]
Default	0000 0000

85h Sleep Mode Baseline Register 2 (RO)

Bit	D7:D0
Name	SLB[7:0]
Default	0000 0000

SLB Sleep Mode Baseline
Read only. Value for reference

86h Slider1 Status Register 1 (RO)

Bit	D7	D6:D0
Name	ACT	INIP
Default	0	0000000

ACT Slider is active

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0 Disable slider
1 Enable slider
Initial position

INIP

87h Slider1 Status Register 2 (RO)

Bit	D7	D6:D0
Name	DIR	ENDP
Default	0	0000000

DIR Direction of Slide1
0 Rotate to left
1 Rotate to right
ENDP End position of the slider

88h Slider1 Status Register 3 (RW)

Bit	D7	D6:D0
Name	STA	DUR
Default	1	0000000

STA Status of Slider1
0 Wheel
1 Slider
STA is the only bit for write.
DUR Duration
The duration between initial position to end position. Every DUR bit increase presents 0.1s.

89h Slider2 Status Register 1 (RO)

Bit	D7	D6:D0
Name	ACT	INIP
Default	0	0000000

ACT Slider2 is active
0 Disable slider
1 Enable slider
INIP Initial position

8Ah Slider2 Status Register 2 (RO)

Bit	D7	D6:D0
Name	DIR	ENDP
Default	0	0000000

DIR Direction of Slide2
0 Rotate to left
1 Rotate to right
ENDP End position of the slider

8Bh Slider2 Status Register 3 (RW)

Bit	D7	D6:D0
Name	STA	DUR
Default	0	0000000

STA Status of Slider2
0 Wheel
1 Slider
DUR Duration
The duration between initial position to end position. Every DUR bit increase presents 0.1s.

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8Ch Slider1 Map Register 1 (RW)

Bit	D7:D0
Name	S1K1[7:0]
Default	0000 1000

8Dh Slider1 Map Register 2 (RW)

Bit	D7:D0
Name	S1K2[7:0]
Default	0000 1001

8Eh Slider1 Map Register 3 (RW)

Bit	D7:D0
Name	S1K3[7:0]
Default	0000 1010

8Fh Slider1 Map Register 4 (RW)

Bit	D7:D0
Name	S1K4[7:0]
Default	0000 1011

90h Slider1 Map Register 5 (RW)

Bit	D7:D0
Name	S1K5[7:0]
Default	0000 1100

91h Slider1 Map Register 6 (RW)

Bit	D7:D0
Name	S1K6[7:0]
Default	0000 1101

92h Slider1 Map Register 7 (RW)

Bit	D7:D0
Name	S1K7[7:0]
Default	0000 0000

93h Slider1 Map Register 8 (RW)

Bit	D7:D0
Name	S1K8[7:0]
Default	0000 0000

S1Kx

Slider1 Keyx Map table

Slider1 KEYx is mapped to Touch Key S1Kx[7:0]

94h-9Bh Slider2 Map Register 1-8 (RW)

Bit	D7:D0
Name	S2Kx[7:0]
Default	0000 0000

S2Kx

Slider2 Keyx Map table

Slider2 KEYx is mapped to Touch Key S2Kx[7:0]

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9Ch Self-Test Item Register (RW)

Bit	D7:D0
Name	STI [7:0]
Default	0000 0000

STI

Self-Test Item

WRITE

- 01 CPU
- 02 PC
- 03 Stack
- 04 Flash
- 05 SRAM
- 06 Clock
- 07 INT
- 08 Touch Key

READ

- 00 Self-Test is completed
- Not 00 Self-Test is busy

9Dh Self-Test Ram Start Address Register 1 (RW)

Bit	D7:D0
Name	STADR[15:8]
Default	0000 0000

9Eh Self-Test Ram Start Address Register 2 (RW)

Bit	D7:D0
Name	STADR [7:0]
Default	0000 0000

STADR

Self-Test Ram Start Address

9Fh Self-Test Ram Size Register 1 (RW)

Bit	D7:D0
Name	STRAMSIZE[15:8]
Default	0000 0000

A0h Self-Test Ram Size Register 2 (RW)

Bit	D7:D0
Name	STRAMSIZE[7:0]
Default	0000 0000

STRAMSIZE

Self-Test Ram Size

A1h Self-Test Result Register (RO)

Bit	D7:D0
Name	STR[7:0]
Default	0000 0000

STR

Self-Test Result

- 5Ah Test Result OK
- Not 5Ah Error

A2h – FFh Reserved

Bit	D7:D0
Name	-
Default	-

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Reserved

6.4 Page 1 Registers (For Expand Memory)

100h Chip Part Number Register (RO)

Bit	D7:D0
Name	CPN[7:0]
Default	0001 0111

CPN

Chip Part Number
Chip's part number 17h

101h Chip Version Register 1 (RO)

Bit	D7:D0
Name	CV1[7:0]
Default	-

CV1

Chip Version information 1

102h Chip Version Register 2 (RO)

Bit	D7:D0
Name	CV2[7:0]
Default	-

CV2

Chip Version information 2
CV1 & CV2 bytes contain chip revision. CV1 indicates mask set version. CV2 indicates minor version.

103h Firmware Version Register (RO)

Bit	D7:D0
Name	FV1[2:0] FV2[2:0] FV3[1:0]
Default	011 000 00

FV

Firmware Version
Default version is 3.0.0

FV1[2:0]

Major version

FV2[2:0]

Minor version

FV3[1:0]

Patch version

104h Run Version Register (RW)

Bit	D7:D0
Name	RV1[2:0] RV2[2:0] RV3[1:0]
Default	011 000 00

RV

Run Version
Set run firmware version and the default value equals to the default value of the firmware version register.

RV1[2:0]

Major version

RV2[2:0]

Minor version

RV3[1:0]

Patch version

105h Main Control Register (WO)

Bit	D7	D6	D5	D4	D3	D2	D1	D0
Name	SR	RD	-	SP	SS	DW	DS	-
Default	0	0	0	0	0	0	0	0

SR

System Reset
1 System reset

RD

Reset All Parameters to Manufacturer Default Setting.
1 Reset all user-defined parameters to manufacture default setting.

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SP	Sleep Mode
	1 Sleep mode
SS	Save User-Defined Parameters
	1 Save current parameters into flash.
DW	Deep Sleep Wake Up Reset Baseline
	1 Reset touch key baseline after waking up from deep sleep mode.
DS	Deep Sleep Mode
	1 Keep sleep until waking up by I2C SDA falling edge.

106h Switch Page (RW)

Bit	D7	D6	D5	D4	D3	D2	D1	D0
Name	-	-	-	-	-	-	-	FLAG
Default	0	0	0	0	0	0	0	0

FLAG=0 Page 0 (Address: 0x00~0xFF)

FLAG=1 Page 1 (Address: 0x100~0x1FF)

107h~108h Key Status Register 1 (RO)

Bit	D7:D0
Name	KS[7:0]
Default	0000 0000

KSx Key0~Key7 Status
If the key is detected as pressed, the corresponding bit (KSx) will be set to "1".
0 Not detected.
1 Key is detected.

Key Status Register 2 (RO)

Bit	D7:D0
Name	KS[15:8]
Default	0000 0000

KSx Key8~Key15 Status
If the key is detected as pressed, the corresponding bit (KSx) will be set to "1".
0 Not detected.
1 Key is detected.

109h Buzzer Register (W)

Bit	D7:D0
Name	BM[7:0]
Default	-

BM Buzzer Register Write
Buzzer data or stop command

109h Buzzer Register (R)

Bit	D7:D0
Name	BM[7:0]
Default	0000 1010

BM Buzzer Register Read
It shows the available tone buffer size. IS31SE5117A has 10 built-in note buffers.

10Ah~119h KEY0~KEY15 Finger Threshold Register (RW)

Bit	D7:D0
Name	KEYx_TH[7:0]
Default Key0~Key7	0101 0000

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Default Key8–Key15	0010 1000
---------------------------	-----------

KEYx_TH Finger threshold of each key. It is used with hysteresis to determine the key state.

11Ah~129h KEY0~KEY15 Noise Threshold Register (RW)

Bit	D7:D0
Name	KEYx_NTH[7:0]
Default Key0–Key7	0010 1000
Default Key8–Key15	0001 0100

KEYx_NTH Noise threshold of each key
Baseline needs to be updated if the difference (baseline and raw count) is less than the noise threshold.

12Ah~139h KEY0~KEY15 Negative Noise Threshold Register (RW)

Bit	D7:D0
Name	KEYx_NNTH[7:0]
Default Key0–Key7	0010 1000
Default Key8–Key15	0001 0100

KEYx_NNTH Negative noise threshold of each key.

13Ah~149h KEY0~KEY15 Low Baseline Reset Register (RW)

Bit	D7:D0
Name	RCx[7:0]
Default	0001 1110

RCx Reset Count

Low baseline reset count of each key. A reset count increases one if the absolute $|\text{raw count} - \text{baseline}| > \text{absolute}[\text{negative noise threshold}]$. Once the reset count exceeds the low baseline reset register value, the baseline is reset to the current raw count. The reset count will be reset to 0 if the absolute $|\text{raw count} - \text{baseline}| \leq \text{absolute}[\text{negative noise threshold}]$.

14Ah~159h KEY0~KEY15 Hysteresis Register (RW)

Bit	D7:D0
Name	HYSTERESISx[7:0]
Default Key0–Key7	0000 1000
Default Key8–Key15	0000 0100

HYSTERESISx Hysteresis of each key

15Ah~169h KEY0~KEY15 On Debounce Register (RW)

Bit	D7:D0
Name	DEBOUNCEx[7:0]
Default	0000 0011

DEBOUNCEx Debounce number of each key. When the acquired number $>$ debounce setting value, then the key is granted as ON state.

16Ah~16Bh Key Interrupt Enable Register (RW)

Bit	D7:D0
Name	INTEN[7:0]
Default	0000 0000

The Interrupt Enable Register determines whether a key causes the interrupt pin to be asserted when it is detected touched with the key's interrupt enable bit set.

INTEN Key Interrupt Enable
0 Disable

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1 Enable

The default value for Interrupt Enable Registers is interrupt disable. Setting INE bit of Interrupt Configuration Register (C3h) to “1”, INTB pin will generate an interrupt signal.

16Ch GPIO Value Register 1 (R/W)

Bit	D7:D1
Name	GPV [7:0]
Default	0000 1110

16Dh GPIO Value Register 2 (R/W)

Bit	D7:D0
Name	GPV [15:8]
Default	0000 0000

GPV GPIO Value
Define GPIO values.
0 GPIO=0, when GPE is enabled.
1 GPIO=1, when GPE is enabled.

16Eh GPIO Enable Register 1 (R/W)

Bit	D7:D0
Name	GPE [7:0]
Default	0111 0000

16Fh GPIO Enable Register 2 (R/W)

Bit	D7:D0
Name	GPE [15:8]
Default	0000 0000

GPE GPIO Enable
0 Disable GPIO function
1 Enable GPIO function

170h GPIO Map Register 1 (R/W)

Bit	D7:D4	D3:D0
Name	GM1[3:0]	GM0[3:0]
Default	0000	0000

171h GPIO Map Register 2 (R/W)

Bit	D7:D4	D3:D0
Name	GM3[3:0]	GM2[3:0]
Default	0000	0000

172h GPIO Map Register 3 (R/W)

Bit	D7:D4	D3:D0
Name	GM5[3:0]	GM4[3:0]
Default	0001	0010

173h GPIO Map Register 4 (R/W)

Bit	D7:D4	D3:D0
Name	GM7[3:0]	GM6[3:0]
Default	0000	0011

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174h GPIO Map Register 5 (R/W)

Bit	D7:D4	D3:D0
Name	GM9[3:0]	GM8[3:0]
Default	0000	0000

175h GPIO Map Register 6 (R/W)

Bit	D7:D4	D3:D0
Name	GM11[3:0]	GM10[3:0]
Default	0000	0000

176h GPIO Map Register 7 (R/W)

Bit	D7:D4	D3:D0
Name	GM13[3:0]	GM12[3:0]
Default	0000	0000

177h GPIO Map Register 8 (R/W)

Bit	D7:D4	D3:D0
Name	GM15[3:0]	GM14[3:0]
Default	0000	0000

GMx [3:0]

Map touch key channel to GPIOx

The variable x is used to express which touch key channel. GMx [3:0] shows which GPIO maps to the touch key channel.

Below is GMx [3:0] value mapping to IS31SE5117A Pin number for your reference.

IS31SE5117A Pin #	GMx [3:0]
P1	0
P2	1
P3	2
P4	3
P9	4
P10	5
P11	6
P12	7
P13	8
P14	9
P15	10
P16	11
P17	12
P18	13
P19	14
P20	15

178h GPIO Toggle Enable Register 1 (R/W)

Bit	D7:D0
Name	TOEN [7:0]
Default	0001 0000

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179h GPIO Toggle Enable Register 2 (R/W)

Bit	D7:D0
Name	TOEN [15:8]
Default	0000 0000

TOENx

Enable GPIO Toggle Mode

0 Disable Touch Key channel to enter GPIO Toggle Mode.

1 Enable Touch Key channel to enter GPIO Toggle Mode.

17Ah Key Scan Once Register (RW)

Bit	D7:D2	D1	D0
Name	SC	TR	EN
Default	0000	00	00

TR

Write 1 Trigger one scan

Read 1 Busy

Read 0 Data ready

EN

Enable Key Scan Once

0 Continuous scan of all enabled keys

1 Scan all enabled keys once

17Bh Table Ready Mark Register (RO)

Bit	D7	D6:D0
Name	INIRDY	MARK[6:0]
Default	0	0000000

INIRDY

Touch Key Init Ready

1 Touch key is initializing

0 Touch key initialization is completed

MARK

This register is used by the firmware to indicate parameters are correctly programmed.

Ready/Fail status

00 ready

Others not ready

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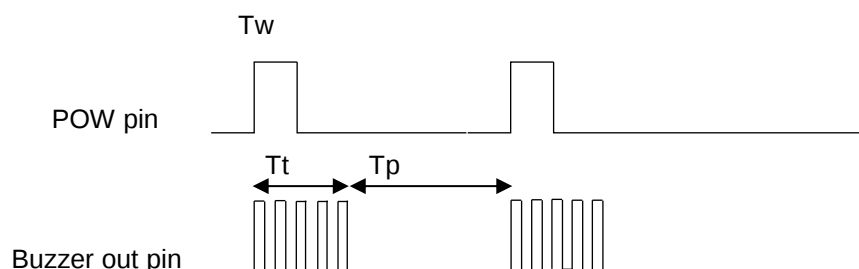
7. BUZZER / MELODY APPLICATION

09h Buzzer/Melody Register (W)

Bit	D7:D0
Name	BM
Default	-

1st byte 2nd byte 3rd byte 4th byte

Scale ID	Tt	Tw	TP
----------	----	----	----



Tt, Tw, and Tp range from 0 to 255 @ 4ms step

A Tone played duration is defined as Tt + Tp.

The support scale is from 3A to 8G#.

Frequencies for equal-tempered scale, A4 = 440 Hz "Middle C" is C4												
	3	freq	divisor	freq error	4	freq	divisor	freq error	5	freq	divisor	freq error
C					3	261.6	1911	0.01%	15	523.3	956	-0.05%
C#					4	277.2	1804	-0.01%	16	554.4	902	-0.01%
D					5	293.7	1703	-0.02%	17	587.3	851	0.04%
D#					6	311.1	1607	0.00%	18	622.3	804	-0.06%
E					7	329.6	1517	-0.01%	19	659.3	758	0.06%
F					8	349.2	1432	-0.02%	20	698.5	716	-0.02%
F#					9	370.0	1351	0.03%	21	740.0	676	-0.05%
G					10	392.0	1276	-0.04%	22	784.0	638	-0.04%
G#					11	415.3	1204	-0.01%	23	830.6	602	-0.01%
A	0	220.0	2273	-0.01%	12	440.0	1136	0.03%	24	880.0	568	0.03%
A#	1	233.1	2145	0.01%	13	466.2	1073	-0.04%	25	932.3	536	0.05%
B	2	246.9	2025	-0.01%	14	493.9	1012	0.04%	26	987.8	506	0.04%
	6	freq.	divisor	Freq error	7	freq	divisor	Freq error	8	freq	divisor	Freq error
C	27	1046.5	478	-0.05%	39	2093.0	239	-0.05%	51	4186.0	119	0.37%
C#	28	1108.7	451	-0.01%	40	2217.5	225	0.21%	52	4434.9	113	-0.23%
D	29	1174.7	426	-0.08%	41	2349.3	213	-0.08%	53	4698.6	106	0.39%
D#	30	1244.5	402	-0.06%	42	2489.0	201	-0.06%	54	4978.0	100	0.44%
E	31	1318.5	379	0.06%	43	2637.0	190	-0.21%	55	5274.0	95	-0.21%
F	32	1396.9	358	-0.02%	44	2793.8	179	-0.02%	56	5587.7	89	0.54%
F#	33	1480.0	338	-0.05%	45	2960.0	169	-0.05%	57	5919.9	84	0.55%

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Frequencies for equal-tempered scale, A4 = 440 Hz "Middle C" is C4												
G	34	1568.0	319	-0.04%	46	3136.0	159	0.28%	58	6271.9	80	-0.35%
G#	35	1661.2	301	-0.01%	47	3322.4	150	0.33%	59	6644.9	75	0.33%
A	36	1760.0	284	0.03%	48	3520.0	142	0.03%				
A#	37	1864.7	268	0.05%	49	3729.3	134	0.05%				
B	38	1975.5	253	0.04%	50	3951.1	127	-0.36%				

Scale ID(Sid): 0 is 3A, 1 is 3A#, 2 is 3B

09h Buzzer/Melody Register (W)

Bit	D7:D0
Name	BM
Default	-

Clear Melody buffer and stop play.

09h Buzzer/Melody Register (R)

Bit	D7:D0
Name	BM
Default	0000 1010

BM Buzzer/Melody Register Read. It shows the available tone buffer size. IS31SE5117A has 10 built-in note buffers.

I2C command format - Each node is composed of 4-byte data, and the incomplete note will be ignored. The incoming note data will be ignored if the FIFO is full)

0x78, 0xF0, (Sid, Tt, Tw, Tp), (Sid, Tt, Tw, Tp),

0x78, 0xF0, 0xFF stop the melody play and clear the FIFO

0x78, 0xF0 Set the register number to 0xF0

0x79 Read FIFO remaining length

Reference schematic and tone waveform are introduced as follows:

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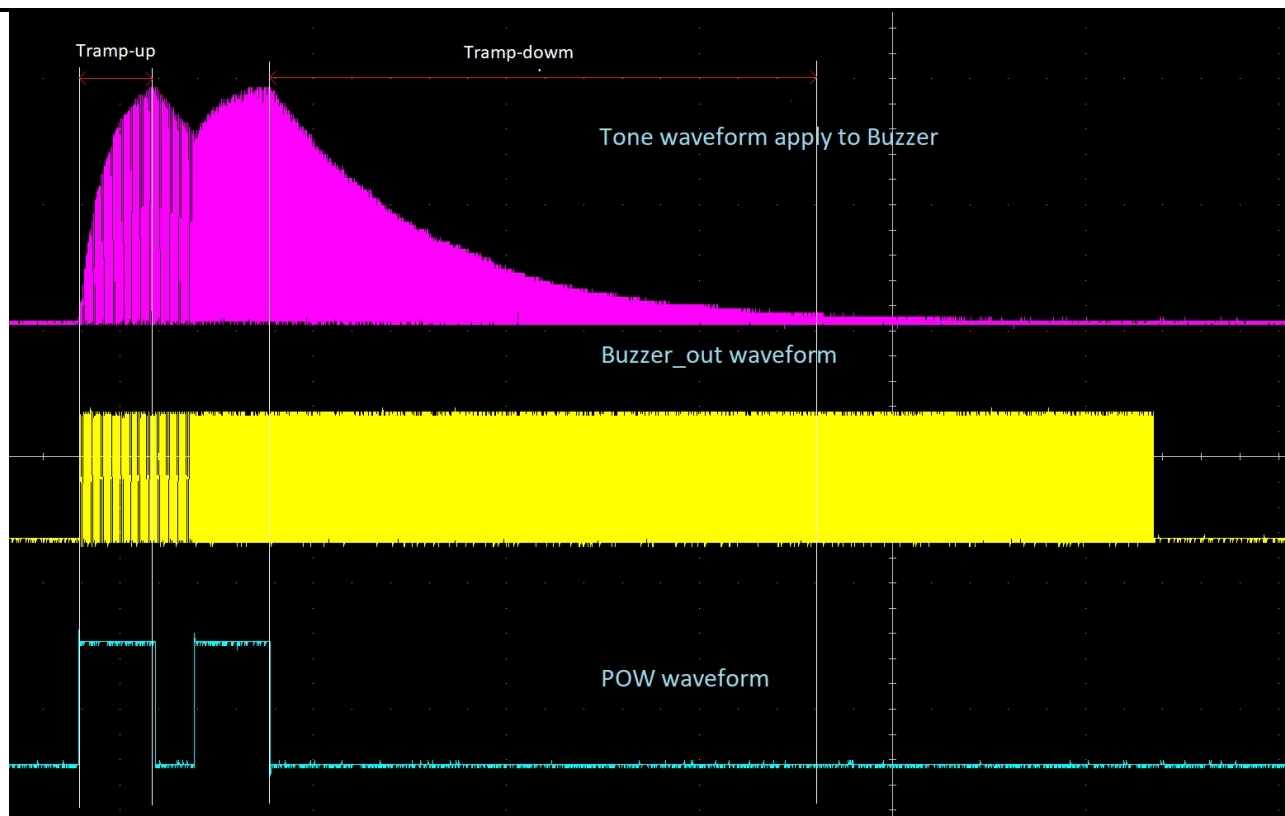


Figure 7-1 Buzzer/ Melody waveform example

Note:

Tramp-up: 100R as below Figure 7-2 decides the signal ramp-up rate.

Tramp-down: The signal ramps down because POW is low and 47uF capacitor as below Figure 7-2 decides the ramp-down rate.

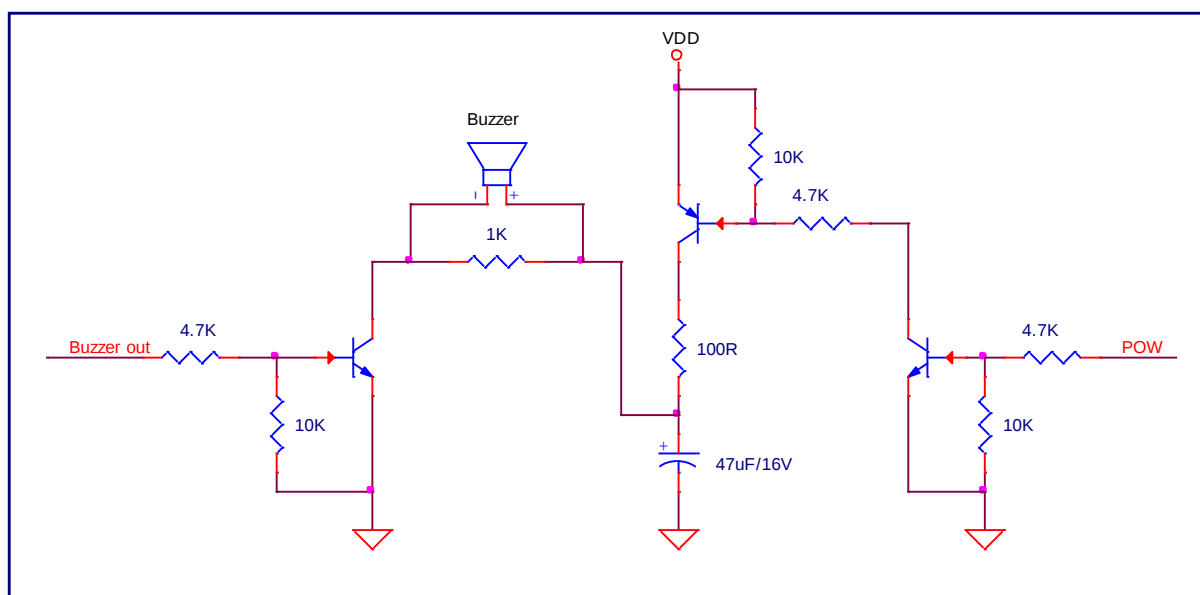


Figure 7-2 Typical application circuit for Melody

6Ah Buzzer Pin Select Register 1

Bit	D7:D0
Name	BPS1[7:0]
Default	---- -- 1

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6Bh Buzzer Pin Select Register 2

Bit	D0
Name	BPS2[7:0]
Default	---- --

BPS1/2

Buzzer output Select 1/2

Enable BPS1[0] will set Pin1 as the Buzzer output pin.

BPS1[7:1] & BPS2[7:0] unused register bits.

6Ch Enable Buzzer Power Register 1

Bit	D7:D0
Name	EBP1[7:0]
Default	---- --

6Dh Enable Buzzer Power Register 2

Bit	D7:D0
Name	EBP2[7:0]
Default	---0----

EBP1/2

Buzzer Power Select ½

EBP1[7:0] unused register.

EBP2[4] maps to KEY12. Writing 1 to EBP2[4] will enable KEY12 as the Buzzer Power. Setting other EBP2 bits doesn't work.

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8. TYPICAL APPLICATION INFORMATION

The IS31SE5117A is an ultra-low power, fully integrated 16-channel solution for capacitive touch-buttons applications. The chip allows electrodes to project sense fields through any dielectric material such as glass or plastic.

8.1 SENSITIVITY ADJUSTING

Sensitivity can be adjusted by the external capacitor or the internal register.

A higher capacitor value will yield lower detection sensitivity. A lower capacitor value will yield higher detection sensitivity.

8.2 INTERRUPT

Touch key detection event will trigger INTB pin. The INTB pin will be driven low when the selected channel is pressed or released.

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9. CLASSIFICATION REFLOW PROFILE

Profile Feature	Pb-Free Assembly
Preheat & Soak Temperature min (T _{smin}) Temperature max (T _{smax}) Time (T _{smin} to T _{smax}) (t _s)	150°C 200°C 60-120 seconds
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.
Liquidous temperature (T _L) Time at liquidous (t _L)	217°C 60-150 seconds
Peak package body temperature (T _p)*	Max 260°C
Time (t _p)** within 5°C of the specified classification temperature (T _c)	Max 30 seconds
Average ramp-down rate (T _p to T _{smax})	6°C/second max.
Time 25°C to peak temperature	8 minutes max.

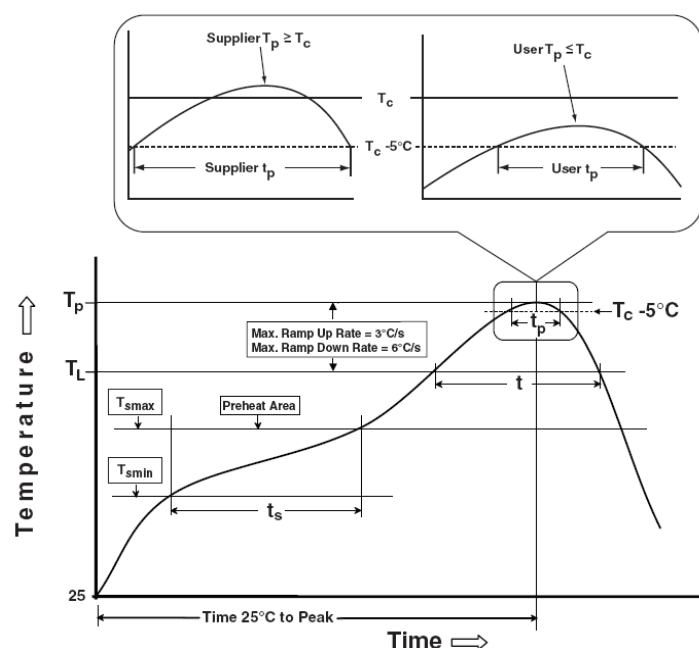


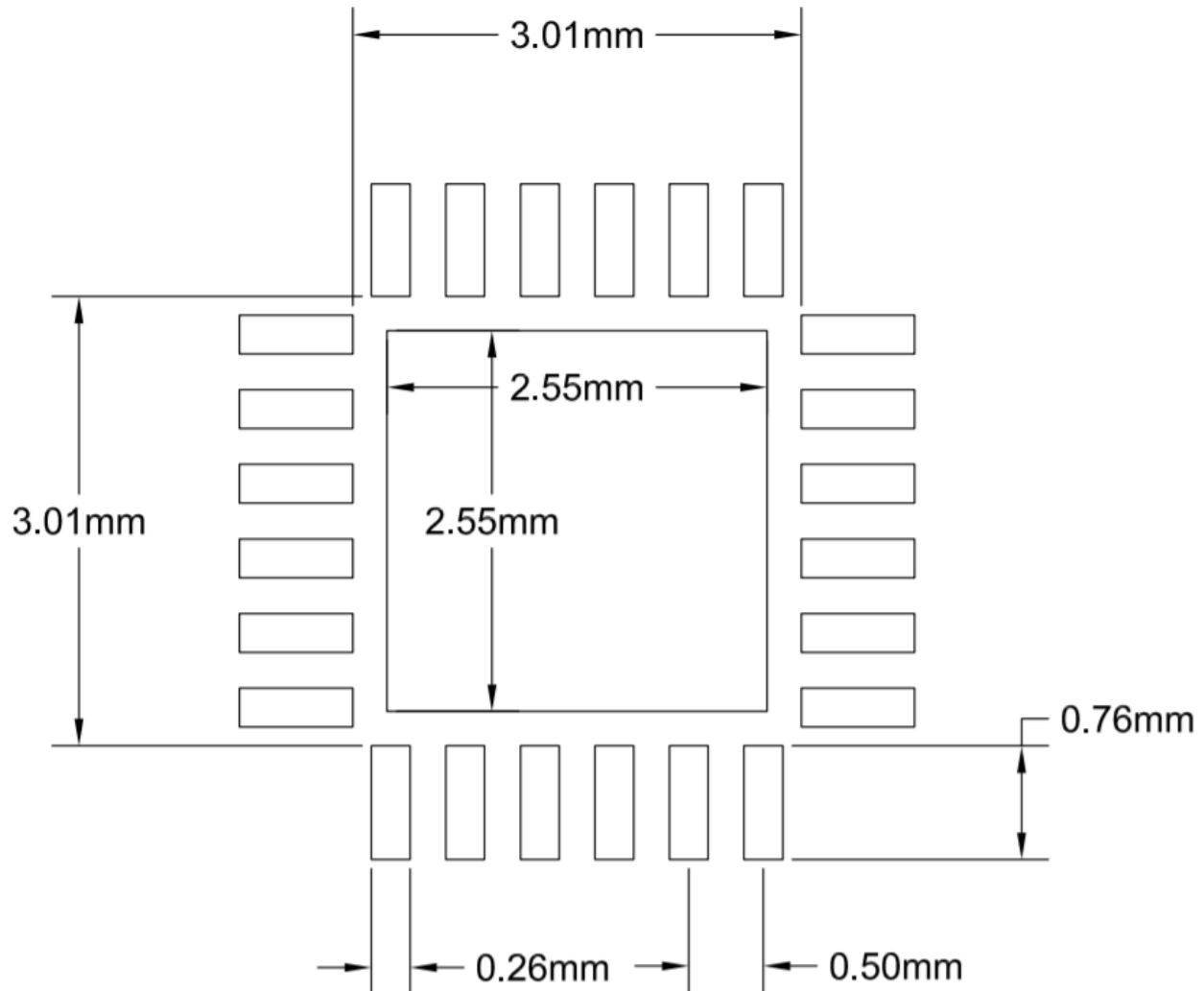
Figure 9-1 Classification Profile

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10. PACKAGE INFORMATION

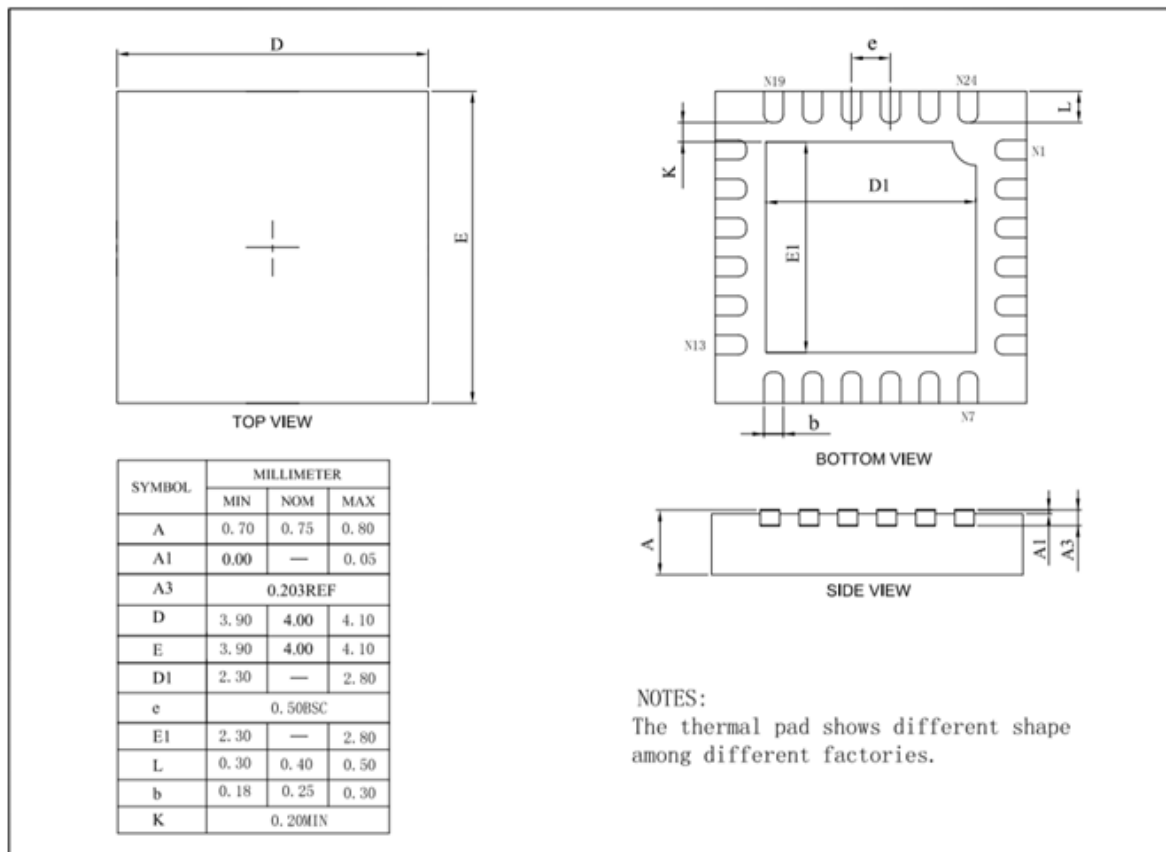
10.1 24-pin QFN

10.1.1 RECOMMENDED LAND PATTERN



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10.1.2POD



Note:

1. Land pattern complies with IPC-7351.
2. This document (including dimensions, notes & specs) is a recommendation based on typical circuit board manufacturing parameters. Since land pattern design depends on many unknown factors (e.g., user's board manufacturing specs), user must make own decisions

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11. REVISIONS

Revision	Detailed Information	Date
A	First formal release	2023.07.26